CD74AC175 QUADRUPLE D-TYPE FLIP-FLOP WITH CLEAR SCHS347 – APRIL 2003

- AC Types Feature 1.5-V to 5.5-V Operation and Balanced Noise Immunity at 30% of the Supply Voltage
- Buffered Inputs
- Contains Four Flip-Flops With Double-Rail Outputs
- Speed of Bipolar F, AS, and S, With Significantly Reduced Power Consumption
- Balanced Propagation Delays
- ±24-mA Output Drive Current
 Fanout to 15 F Devices
- SCR-Latchup-Resistant CMOS Process and Circuit Design
- Exceeds 2-kV ESD Protection Per MIL-STD-883, Method 3015
- Applications Include:
 - Buffer/Storage Registers
 - Shift Registers
 - Pattern Generators

description/ordering information

This positive-edge-triggered D-type flip-flop has a direct clear (CLR) input. The CD74AC175 features complementary outputs from each flip-flop.

Information at the data (D) inputs meeting the setup time requirements is transferred to the outputs on the positive-going edge of the clock (CLK) pulse. Clock triggering occurs at a particular voltage level and is not directly related to the transition time of the positive-going edge of CLK. When CLK is at either the high or low level, the D input has no effect at the output.

ORDERING INFORMATION

TA	PACKAGET		ORDERABLE PART NUMBER	TOP-SIDE MARKING
	SOIC – M	Tube	CD74AC175M	AC175M
–55°C to 125°C	SOIC - M	Tape and reel	CD74AC175M96	ACT7 SIVI

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE

	(eac	h flip-fl	op)		
INPUTS			OUTPUTS		
CLR	CLK	D	Q	Q	
L	Х	Х	L	Н	
н	\uparrow	Н	н	L	
Н	Ŷ	L	L	н	
н	L	Х	Q ₀	\overline{Q}_0	



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

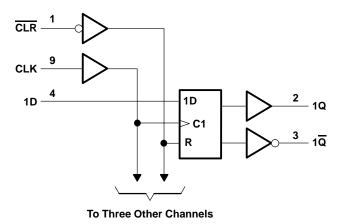


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I		ACK. P VI		_
CLR [1Q [1Q [2D [2Q [2Q [GND]	1 2 3 4 5 6 7 8	σ	16 15 14 13 12 11 10 9	V _{CC} 4Q 4Q 4D 3D 3Q 3Q

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logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}	–0.5 V to 6 V
Input clamp current, I _{IK} (V _I < 0 V or V _I > V _{CC}) (see Note 1)	±20 mA
Output clamp current, I_{OK} (V _O < 0 V or V _O > V _{CC}) (see Note 1)	±50 mA
Continuous output current, $I_O (V_O > 0 V \text{ or } V_O < V_{CC})$	±50 mA
Continuous current through V _{CC} or GND	±200 mA
Package thermal impedance, θ_{JA} (see Note 2)	73°C/W
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 3)

				25°C	–55°C to 125°C		–40°C to 85°C		UNIT	
			MIN	MAX	MIN	MAX	MIN	MAX		
VCC	Supply voltage		1.5	5.5	1.5	5.5	1.5	5.5	V	
		V _{CC} = 1.5 V	1.2		1.2		1.2		V	
VIH	High-level input voltage	$V_{CC} = 3 V$	2.1		2.1		2.1			
		$V_{CC} = 5.5 V$	3.85		3.85		3.85			
		V _{CC} = 1.5 V		0.3		0.3		0.3		
VIL	VIL Low-level input voltage	$V_{CC} = 3 V$		0.9		0.9		0.9	V	
		V _{CC} = 5.5 V		1.65		1.65		1.65		
VI	Input voltage		0	VCC	0	VCC	0	VCC	V	
VO	Output voltage		0	VCC	0	VCC	0	VCC	V	
ЮН	High-level output current	V _{CC} = 4.5 V to 5.5 V		-24		-24		-24	mA	
IOL	Low-level output current	V _{CC} = 4.5 V to 5.5 V		24		24		24	mA	
A #/ A	Input transition rise or fell rate	V _{CC} = 1.5 V to 3 V		50		50		50		
$\Delta t / \Delta v$	Input transition rise or fall rate	V_{CC} = 3.6 V to 5.5 V		20		20		20	ns/V	

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		vcc	T _A = 25°C		–55°C to 125°C		–40°C to 85°C		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	
			1.5 V	1.4		1.4		1.4		
		I _{OH} = -50 μA	3 V	2.9		2.9		2.9		
			4.5 V	4.4		4.4		4.4		
∨он	$V_I = V_{IH} \text{ or } V_{IL}$	I _{OH} = -4 mA	3 V	2.58		2.4		2.48		V
		I _{OH} = -24 mA	4.5 V	3.94		3.7		3.8		
		I _{OH} = -50 mA†	5.5 V			3.85				
		I _{OH} = -75 mA†	5.5 V					3.85		
			1.5 V		0.1		0.1		0.1	0.1
		I _{OL} = 50 μA	3 V		0.1		0.1		0.1	
			4.5 V		0.1		0.1		0.1	
VOL	$V_I = V_{IH} \text{ or } V_{IL}$	I _{OL} = 12 mA	3 V		0.36		0.5		0.44	V
		I _{OL} = 24 mA	4.5 V		0.36		0.5		0.44	
		$I_{OL} = 50 \text{ mA}^{\dagger}$	5.5 V				1.65			
		I _{OL} = 75 mA [†]	5.5 V						1.65	
lj	$V_I = V_{CC} \text{ or } GND$		5.5 V		±0.1		±1		±1	μA
ICC	$V_I = V_{CC}$ or GND,	IO = 0	5.5 V		8		160		80	μA
Ci					10		10		10	pF

† Test one output at a time, not exceeding 1-second duration. Measurement is made by forcing indicated current and measuring voltage to minimize power dissipation. Test verifies a minimum 50-Ω transmission-line drive capability at 85°C and 75-Ω transmission-line drive capability at 125°C.

timing requirements over recommended operating free-air temperature range, $V_{CC} = 1.5 V$ (unless otherwise noted)

				C to ⁰C	-40°C to 85°C		UNIT
					MIN	MAX	
fclock	Clock frequency			8		9	MHz
+	Pulso duration	CLR low	50		44		ns
tw	Pulse duration	CLK high or low	63		55		
t _{su}	Setup time before CLK [↑]	Data	2		2		ns
th	Hold time, data after CLK [↑]		2		2		ns
t _{rec}	Recovery time, before CLK↑	CLR↑	1		1		ns



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timing requirements over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted)

				–55°C to 125°C		–40°C to 85°C	
			MIN	MAX	MIN	MAX	
fclock	Clock frequency			71		81	MHz
	t _w Pulse duration	CLR low	5.6		4.9		ns
١W		CLK high or low	7		6.1		
t _{su}	Setup time before CLK [↑]	Data	2		2		ns
th	Hold time, data after $CLK\uparrow$		2		2		ns
t _{rec}	Recovery time, before CLK↑	<u>CLR</u> ↑	1		1		ns

timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted)

				–55°C to 125°C		–40°C to 85°C	
			MIN	MAX	MIN	MAX	
fclock	Clock frequency			100		114	MHz
+	Pulse duration	CLR low	4		3.5		
tw	Fuise duration	CLK high or low	5		4.4		ns
t _{su}	Setup time before CLK^\uparrow	Data	2		2		ns
^t h	Hold time, data after $CLK\uparrow$		2		2		ns
t _{rec}	Recovery time, before CLK^\uparrow	<u>CLR</u> ↑	1		1		ns

switching characteristics over recommended operating free-air temperature range, V_{CC} = 1.5 V, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM TO (INPUT) (OUTPUT)	_	–55°C to 125°C		–40°C to 85°C		UNIT	
		(0011 01)	MIN	MAX	MIN	MAX		
fmax			8		9		MHz	
^t PLH	CLK	Any 0		153		139		
^t PHL	CEK	Any Q		153		139	ns	
^t PLH		Any 0	153			139		
^t PHL	CER	Any Q		153		139	ns	

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM TO (INPUT) (OUTPUT)		–55° 125		–40°(85°		UNIT
	(111 01)		MIN	MAX	MIN	MAX	
fmax			71		81		MHz
^t PLH	CLK	404.0	4.3	17.1	4.4	15.5	ns
^t PHL	CER	Any Q	4.3	17.1	4.4	15.5	
^t PLH		Any Q	4.3	17.1	4.4	15.5	ns
^t PHL	CLR		4.3	17.1	4.4	15.5	115



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switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V, C_L = 50 pF (unless otherwise noted) (see Figure 1)

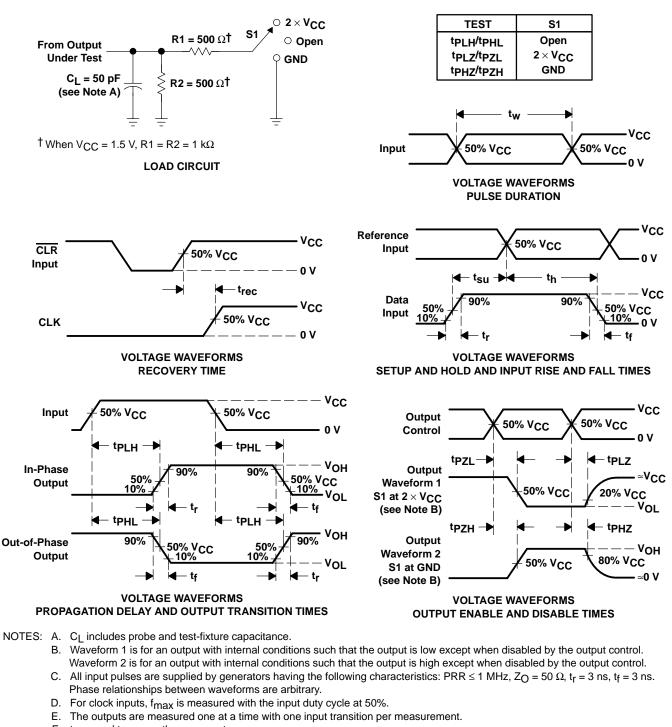
PARAMETER	FROM (INPUT)	ТО (О U ТРUТ)	–55° 125		–40°C to 85°C		UNIT
			MIN	MAX	MIN	MAX	
fmax			100		114		MHz
^t PLH	CLK	Any O	3.1	12.2	3.2	11.1	-
^t PHL	CER	Any Q	3.1	12.2	3.2	11.1	ns
^t PLH		Any Q	3.1	12.2	3.2	11.1	ns
^t PHL	CLR		3.1	12.2	3.2	11.1	115

operating characteristics, V_{CC} = 5 V, T_A = 25° C

PARAMETER				
C _{pd}	Power dissipation capacitance	55	pF	

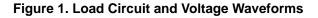


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PARAMETER MEASUREMENT INFORMATION

- F. tpLH and tpHL are the same as tpd.
- G. tp71 and tp7H are the same as ten.
- H. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- I. All parameters and waveforms are not applicable to all devices.







PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
CD74AC175M	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74AC175M96	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74AC175M96E4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74AC175M96G4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74AC175ME4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74AC175MG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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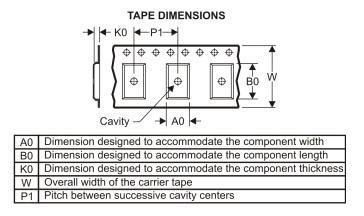
PACKAGE MATERIALS INFORMATION

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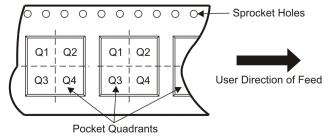
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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



1	*All dimensions are nominal												
	Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
	CD74AC175M96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1

TEXAS INSTRUMENTS

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PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74AC175M96	SOIC	D	16	2500	333.2	345.9	28.6

D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



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D (R-PDSO-G16) PLASTIC SMALL OUTLINE Stencil Openings (Note D) Example Board Layout (Note C) –16x0,55 -14x1,27 -14x1,27 16x1,50 5,40 5.40 Example Non Soldermask Defined Pad Example Pad Geometry (See Note C) 0,60 .55 Example 1. Solder Mask Opening (See Note E) -0,07 All Around

NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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